

## 2A Peak Sink/Source DDR Termination Regulator

### Features

- **Sourcing and Sinking Peak Current up to 2A**
- **VCNTL Supply Voltage Range: 3.1V to 5.5V**
- **VIN Supply Voltage Range: 1.2V to 3.6V**
- **VTT and VTTREF Voltage Tracks at Half the VREF Voltage**
- **VTT and VTTREF Voltage with  $\pm 10\text{mV}$  Accuracy**
- **Excellent Load Transient Response**
- **Stable with 10mF Ceramic Output Capacitor**
- **Current-Limit Protection**
- **Thermal Shutdown Protection**
- **Power-On-Reset Function on VCNTL**
- **S3, S5 Input Signals for ACPI States**
- **Small TDFN2x2-10 Package**
- **Lead Free and Green Devices Available (RoHS Compliant)**

### General Description

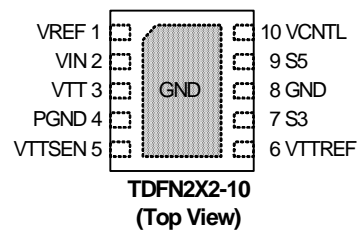
The APL5338E linear regulator is designed to provide a regulated voltage with bi-directional output peak current for DDR-SDRAM termination. The APL5338E integrates two power transistors to source or sink peak current up to 2A. It also incorporates current-limit and thermal shut-down into a single chip.


The output voltage of APL5338E tracks the voltage at VREF pin. An internal resistor divider is used to provide a half voltage of VREF for VTTREF and VTT Voltage. The VTT output voltage is only requiring 10 $\mu\text{F}$  of ceramic output capacitance for stability and fast transient response. The S3 and S5 pins provide the sleep state for VTT (S3 state) and suspend state (S4/S5 state) for device when S5 and S3 are both pulled low the device provides the soft-off for VTT and VTTREF. The TDFN2x2-10 package with a copper pad is available which provides excellent thermal impedance.

### Applications

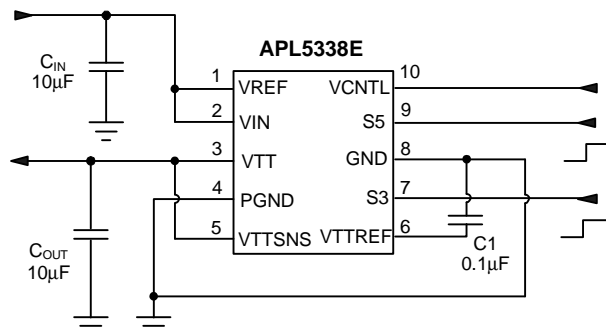
- **DDR 2/3/4 Memory Termination**

### Pin Configuration



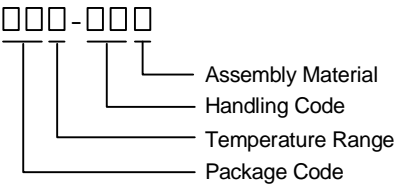
 = Exposed Pad  
(connected to ground plane for better heat dissipation)

### Simplified Application Circuit



ANPEC reserves the right to make changes to improve reliability or manufacturability without notice, and advise customers to obtain the latest version of relevant information to verify before placing orders.

## Ordering and Marking Information

<p>APL5338E    □□□ - □□□</p>  <p>             Assembly Material              Handling Code              Temperature Range              Package Code         </p>	<p>             Package Code              QB : TDFN2x2-10              Operating Ambient Temperature Range              I : -40 to 85 °C              Handling Code              TR : Tape &amp; Reel              Assembly Material              G : Halogen and Lead Free Device         </p>
<p>APL5338E QB :</p> <div style="border: 1px solid black; padding: 2px; display: inline-block; margin-left: 20px;">             5338              X         </div>	<p>XXXXX - Date Code</p>

Note : ANPEC lead-free products contain molding compounds/die attach materials and 100% matte tin plate termination finish; which are fully compliant with RoHS. ANPEC lead-free products meet or exceed the lead-free requirements of IPC/JEDEC J-STD-020D for MSL classification at lead-free peak reflow temperature. ANPEC defines “Green” to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

## Absolute Maximum Ratings (Note 1)

Symbol	Parameter	Rating	Unit
V <sub>CNTL</sub>	VCNTL Supply Voltage (VCNTL to GND)	-0.3 ~ 7	V
V <sub>IN</sub>	VIN Supply Voltage (VIN to GND)	-0.3 ~ V <sub>CNTL</sub> + 0.3	V
V <sub>TT</sub>	VTT Output Voltage (VTT to GND)	-0.3 ~ V <sub>IN</sub> + 0.3	V
V <sub>TTRF</sub>	VTTREF Output Voltage (VTTREF to GND)	-0.3 ~ V <sub>IN</sub> + 0.3	V
V <sub>REF</sub>	VREF Input Voltage (VREF to GND)	-0.3 ~ 7	V
	VTTSENS, S3 and S5 Voltage	-0.3 ~ 7	V
	PGND to GND Voltage	-0.3 ~ 0.3	V
T <sub>J</sub>	Maximum Junction Temperature	150	°C
T <sub>STG</sub>	Storage Temperature Range	-65 ~ 150	°C
T <sub>SDR</sub>	Maximum Lead Soldering Temperature, 10 Seconds	260	°C

Note1: Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

## Thermal Characteristics

Symbol	Parameter	Typical Value	Unit
θ <sub>JA</sub>	Junction-to-Ambient Resistance in Free Air <small>(Note 2)</small>	80	°C/W
	TDFN2x2-10		
θ <sub>JC</sub>	Junction-to-Case Resistance in Free Air	18	°C/W
	TDFN2x2-10		

Note 2 : θ<sub>JA</sub> is measured with the component mounted on a high effective thermal conductivity test board in free air. The exposed pad of TDFN2x2-10 is soldered directly on the PCB.

**Recommended Operating Conditions** (Note 3)

Symbol	Parameter	Range	Unit
V <sub>CNTL</sub>	VCNTL to GND	3.1 ~ 5.5	V
V <sub>IN</sub>	VIN to GND (V <sub>IN</sub> <V <sub>CNTL</sub> +0.3V)	1.2 ~ 3.6	V
V <sub>TT</sub>	VTT to GND (V <sub>TT</sub> =0.5V <sub>REF</sub> )	V <sub>CNTL</sub> =5V	0.5 ~ 1.8
		V <sub>CNTL</sub> =3.3V	0.5 ~ 1.6
V <sub>TTREF</sub>	VTTREF to GND (V <sub>TTREF</sub> =0.5V <sub>REF</sub> )	V <sub>CNTL</sub> =5V	0.5 ~ 1.8
		V <sub>CNTL</sub> =3.3V	0.5 ~ 0.8
V <sub>S3</sub> , V <sub>S5</sub>	S3, S5 to GND	0 ~ 5.5	V
I <sub>VTT</sub>	VTT Output Current (Note 4,5)	V <sub>CNTL</sub> =5V	-1.5 ~ +1.5
		V <sub>CNTL</sub> =3.3V	-1 ~ +1
C <sub>IN</sub>	VIN Input Capacitor	10 ~ 100	μF
C <sub>OUT</sub>	Capacitance of VTT Output Multi-layer Ceramic Capacitor (MLCC)	10 ~ 47	μF
T <sub>A</sub>	Ambient Temperature	-40 ~ 85	°C
T <sub>J</sub>	Junction Temperature	-40 ~ 125	°C

Note 3 : Refer to the typical application circuit.

Note 4 : If the VTT output current is “+1A”, then VTT source would be 1A current, and vice versa.

Note 5 : Refer to the thermal consideration on page 12.

**Electrical Characteristics**

Unless otherwise specified, these specifications apply over V<sub>CNTL</sub>=5V, V<sub>IN</sub>=V<sub>REF</sub>=1.8V, C<sub>IN</sub>=10μF, C<sub>OUT</sub>=10μF and T<sub>A</sub>= -40 ~ 85 °C. Typical values are at T<sub>A</sub>=25°C.

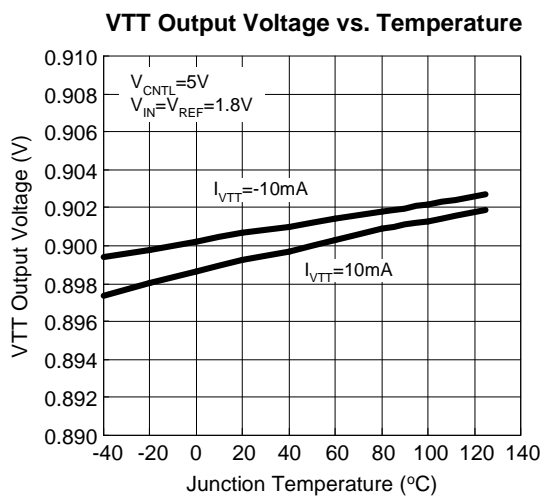
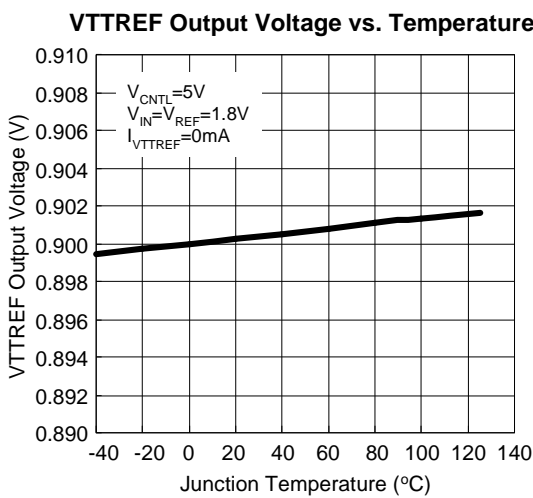
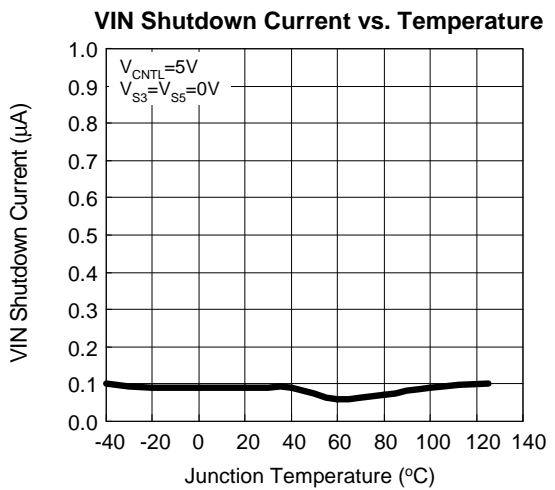
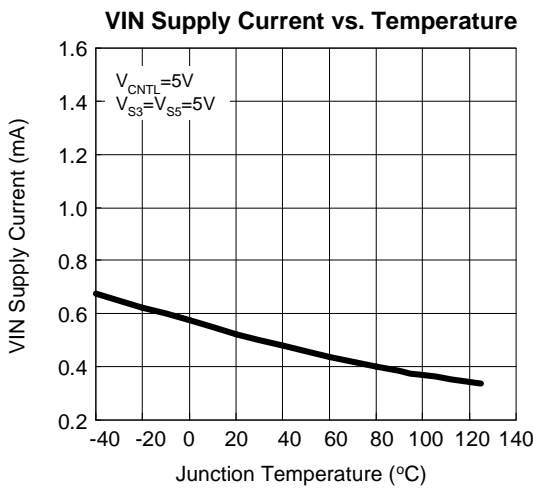
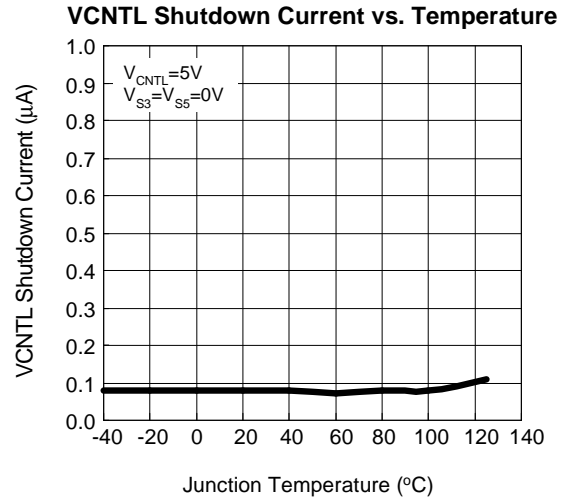
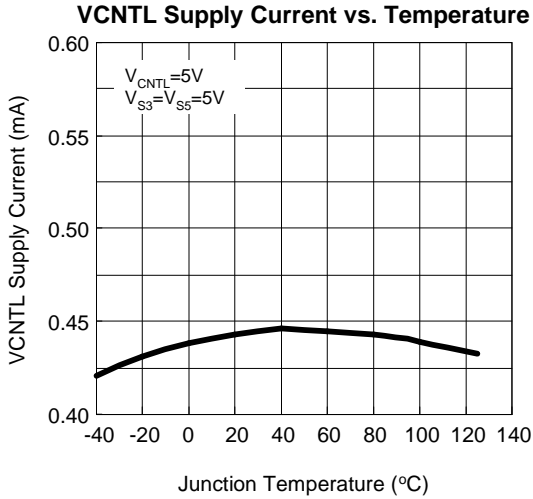
Symbol	Parameter	Test Conditions	APL5338E			Unit
			Min.	Typ.	Max.	
<b>SUPPLY CURRENT</b>						
I <sub>VCNTL</sub>	VCNTL Supply Current	T <sub>J</sub> = 25°C, V <sub>CNTL</sub> =5V, V <sub>S3</sub> =V <sub>S5</sub> =5V, no load	0.2	0.5	1	mA
	VCNTL Standby Current	T <sub>J</sub> = 25°C, V <sub>CNTL</sub> =5V, V <sub>S3</sub> =0V, V <sub>S5</sub> =5V, no load	20	50	80	μA
	VCNTL Shutdown Current	T <sub>J</sub> = 25°C, V <sub>CNTL</sub> =5V, V <sub>S3</sub> =V <sub>S5</sub> =0V, no load, V <sub>IN</sub> =V <sub>REF</sub> =0V	-	0.3	1.0	
V <sub>IN</sub>	VIN Supply Current	T <sub>J</sub> = 25°C, V <sub>CNTL</sub> =5V, V <sub>S3</sub> =V <sub>S5</sub> =5V, no load	0.3	0.6	1.0	mA
	VIN Standby Current	T <sub>J</sub> = 25°C, V <sub>CNTL</sub> =5V, V <sub>S3</sub> =0V, V <sub>S5</sub> =5V, no load	-	5	10	μA
	VIN Shutdown Current	T <sub>J</sub> = 25°C, V <sub>CNTL</sub> =5V, V <sub>S3</sub> =V <sub>S5</sub> =0V, no load, V <sub>IN</sub> =V <sub>REF</sub> =0V	-	0.5	1.0	
<b>INPUT IMPEDANCE</b>						
I <sub>VREF</sub>	VREF Input Impedance	V <sub>CNTL</sub> =5V, V <sub>S3</sub> =V <sub>S5</sub> =5V	1	3	5	μA
I <sub>VTTSENS</sub>	VTTSENS Input Current	V <sub>CNTL</sub> =5V, V <sub>S3</sub> =V <sub>S5</sub> =5V	-	10	-	nA
<b>POWER-ON-RESET (POR) AND LOCKOUT VOLTAGE THRESHOLDS</b>						
	VCNTL POR Voltage Threshold	V <sub>CNTL</sub> rising	2.6	2.8	3.0	V
	VCNTL POR Hysteresis		-	0.2	-	

## Electrical Characteristics (Cont.)

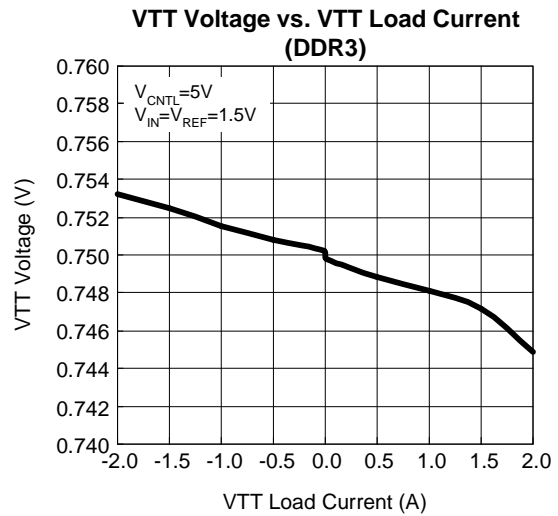
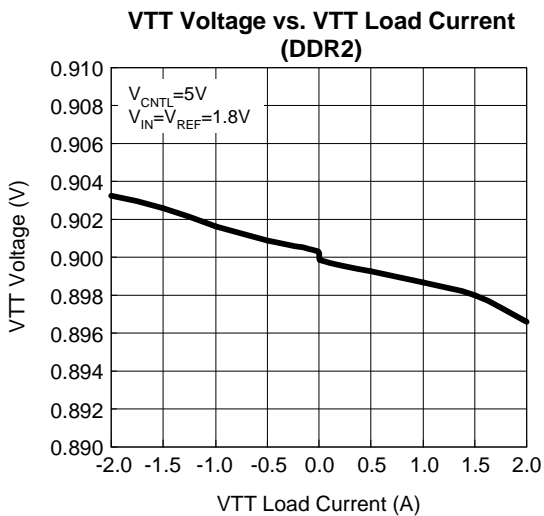
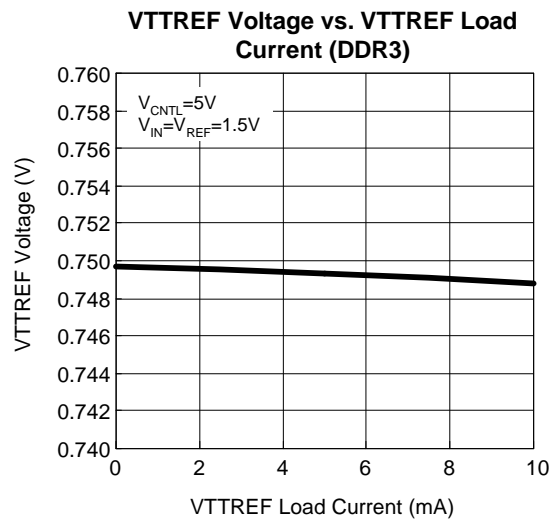
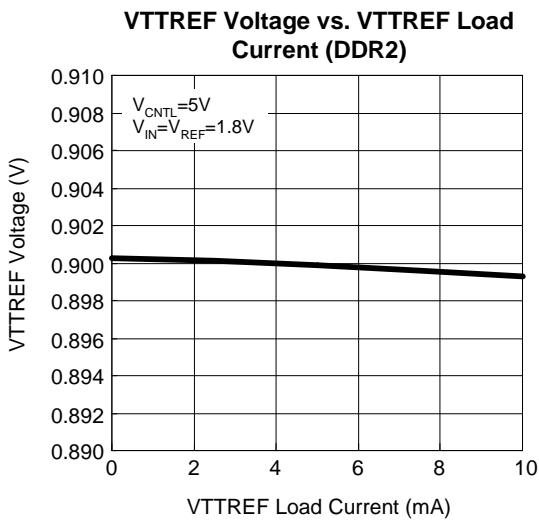
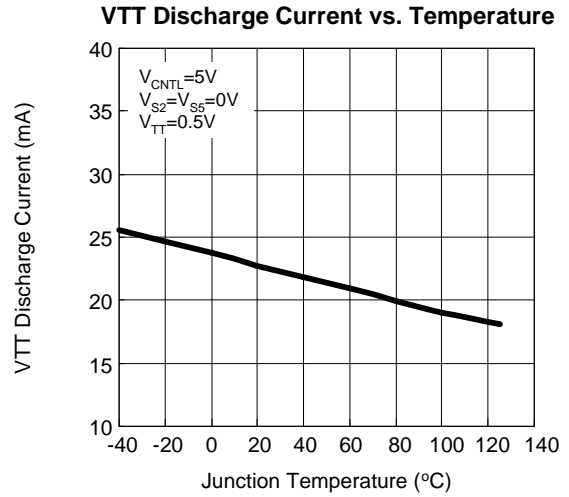
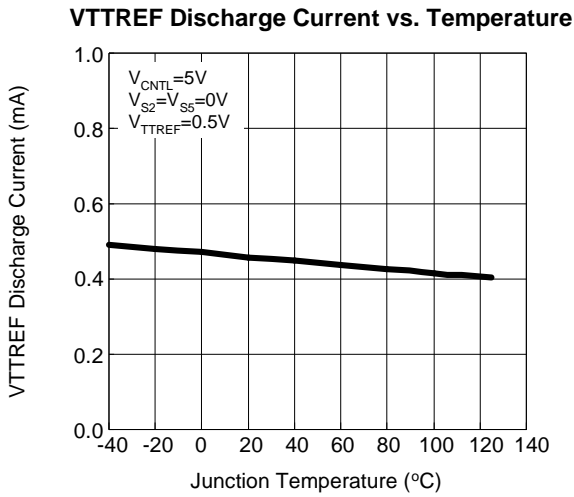
Unless otherwise specified, these specifications apply over  $V_{CNTL}=5V$ ,  $V_{IN}=V_{REF}=1.8V$ ,  $C_{IN}=10\mu F$ ,  $C_{OUT}=10\mu F$  and  $T_A = -40 \sim 85^\circ C$ . Typical values are at  $T_A=25^\circ C$ .

Symbol	Parameter	Test Conditions	APL5338E			Unit
			Min.	Typ.	Max.	
<b>VTT OUTPUT</b>						
	VTT Output Voltage	$V_{IN}=V_{REF}=3.15V$	-	1.575	-	V
		$V_{IN}=V_{REF}=1.8V$	-	0.9	-	
		$V_{IN}=V_{REF}=1.5V$	-	0.75	-	
		$V_{IN}=V_{REF}=1.35V$	-	0.675	-	
		$V_{IN}=V_{REF}=1.2V$	-	0.6	-	
	VTT Output Accuracy to VTTREF	$V_{IN}=V_{REF}=1.2V/1.35V/1.5V/1.8V$ over temperature and load current range	-10	-	10	mV
$I_{LIM}$	VTT Current Limit	$V_{CNTL}=5V$ Sourcing Current	2.8	3.0	3.5	A
		$V_{CNTL}=5V$ Sinking Current	-2.8	-3.0	-3.5	
	VTT Leakage Current	$V_{TT}=0.9V$ , $V_{S3}=0V$ , $V_{S5}=5V$ , $T_J=25^\circ C$	-	2.5	4.0	$\mu A$
	VTTSENS Leakage Current	$V_{TT}=0.9V$ , $T_J=25^\circ C$	-1.0	-	1.0	
	VTT Discharge Current	$V_{TT}=0.5V$ , $V_{S3}=V_{S5}=0V$ , $T_J=25^\circ C$ , $V_{REF}=0V$	15	25	35	mA
<b>VTTREF OUTPUT</b>						
$V_{TTREF}$	VTTREF Output Voltage	$V_{IN}=V_{REF}=1.8V$	-	0.9	-	V
		$V_{IN}=V_{REF}=1.5V$	-	0.75	-	
		$V_{IN}=V_{REF}=1.35V$	-	0.675	-	
		$V_{IN}=V_{REF}=1.2V$	-	0.6	-	
	VTTREF Output Voltage Tolerance to 0.5VREF	$V_{IN}=V_{REF}=1.2V/1.35V/1.5V/1.8V$ , $I_{VTTREF}<10mA$	-10	-	+10	mV
$I_{VTTREF}$	VTTREF Source Current Limit	$V_{TTREF}=0V$	10	20	30	mA
$I_{VTTREFDIS}$	VTTREF Discharge Current	$V_{TTREF}=0.5V$ , $V_{S3}=V_{S5}=0V$ , $T_J=25^\circ C$	0.3	0.5	0.8	
<b>LOGIC THRESHOLD</b>						
$V_{IH}$	High Threshold Voltage	$V_{S3}$ , $V_{S5}$ Rising	1.6	-	-	V
$V_{IL}$	Low Threshold Voltage	$V_{S3}$ , $V_{S5}$ Falling	-	-	0.4	
	S3, S5 Hysteresis		-	0.2	-	
	Leakage Current	S3, S5, $T_J=25^\circ C$	-	-	4	$\mu A$
<b>THERMAL SHUTDOWN</b>						
$T_{SD}$	Thermal Shutdown Temperature	$T_J$ Rising	-	150	-	$^\circ C$
	Thermal Shutdown Hysteresis		-	30	-	

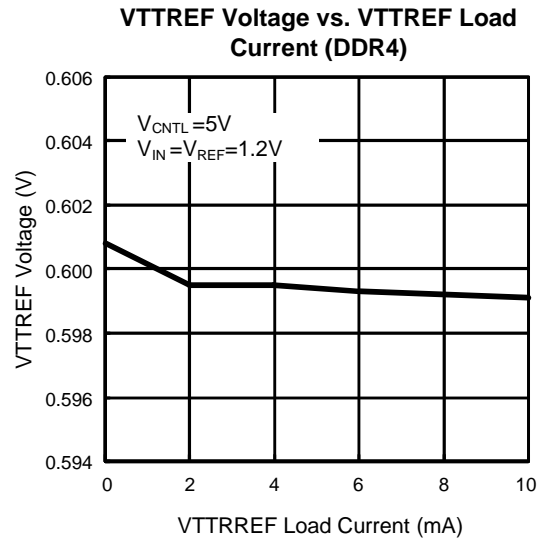
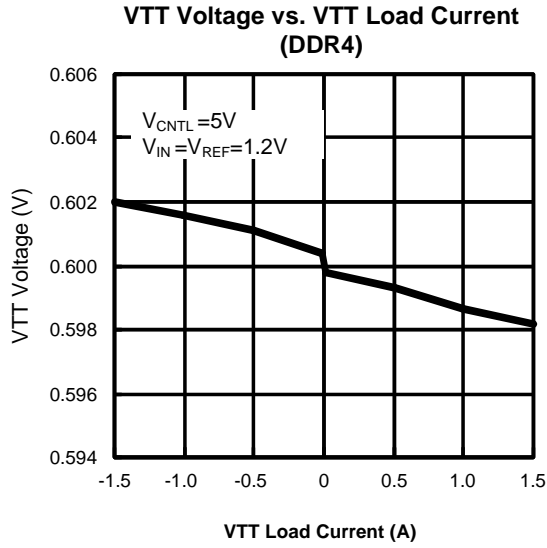
Typical Operating Characteristics



Typical Operating Characteristics (Cont.)



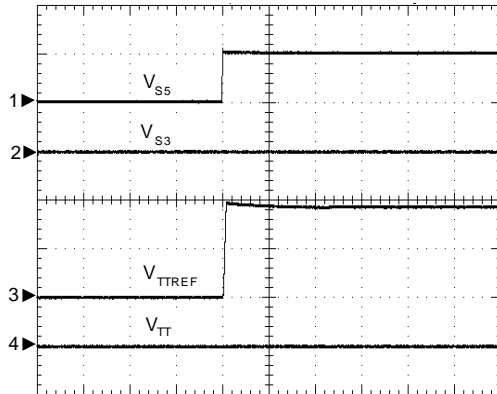
Typical Operating Characteristics (Cont.)



## Operating Waveforms

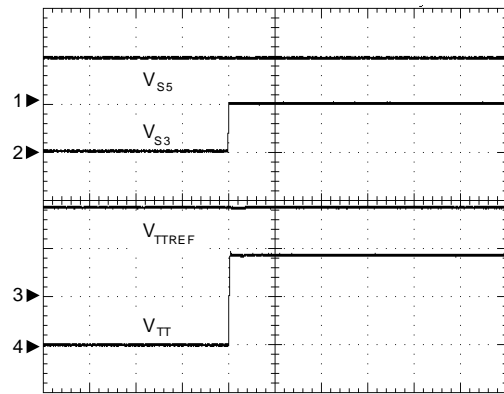
(Refer to the section "Typical Application Circuits"  $V_{CNTL}=5V$ ,  $V_{IN}=V_{REF}=1.8V$ ,  $T_A=25^\circ C$ )

**Startup Waveform-S5 Low to High**



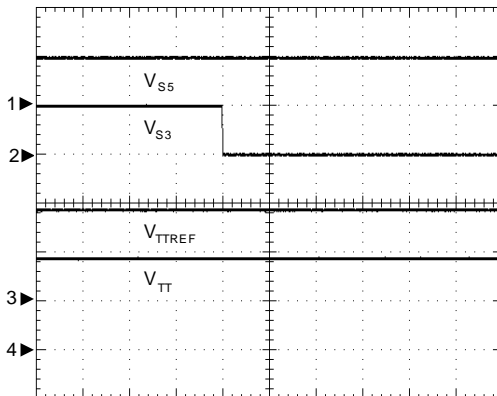
$I_{V_{TT}}=I_{V_{TTREF}}=0A$   
 CH1:  $V_{S5}$ , 5V/Div, DC  
 CH2:  $V_{S3}$ , 5V/Div, DC  
 CH3:  $V_{TTREF}$ , 500mV/Div, DC  
 CH4:  $V_{TT}$ , 500mV/Div, DC  
 TIME:100 $\mu$ s/Div

**Startup Waveform-S3 Low to High**



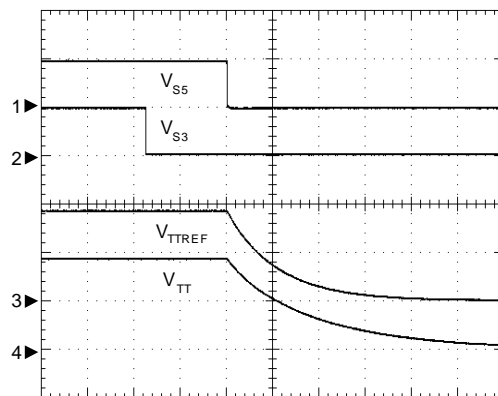
$I_{V_{TT}}=I_{V_{TTREF}}=0A$   
 CH1:  $V_{S5}$ , 5V/Div, DC  
 CH2:  $V_{S3}$ , 5V/Div, DC  
 CH3:  $V_{TTREF}$ , 500mV/Div, DC  
 CH4:  $V_{TT}$ , 500mV/Div, DC  
 TIME:100 $\mu$ s/Div

**Shutdown Waveform-S3 High to Low**



$I_{V_{TT}}=I_{V_{TTREF}}=0A$   
 CH1:  $V_{S5}$ , 5V/Div, DC  
 CH2:  $V_{S3}$ , 5V/Div, DC  
 CH3:  $V_{TTREF}$ , 500mV/Div, DC  
 CH4:  $V_{TT}$ , 500mV/Div, DC  
 TIME:100 $\mu$ s/Div

**Shutdown Waveform-S3 and S5 High to Low**



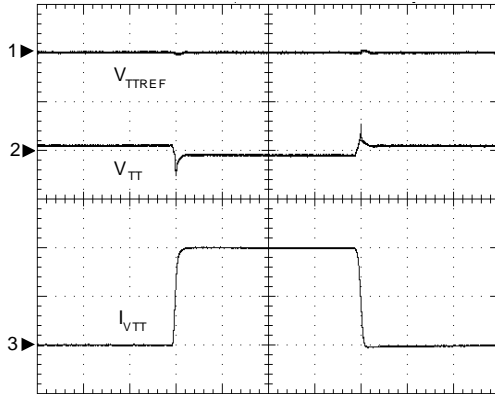
$I_{V_{TT}}=I_{V_{TTREF}}=0A$   
 CH1:  $V_{S5}$ , 5V/Div, DC  
 CH2:  $V_{S3}$ , 5V/Div, DC  
 CH3:  $V_{TTREF}$ , 500mV/Div, DC  
 CH4:  $V_{TT}$ , 500mV/Div, DC  
 TIME:100 $\mu$ s/Div



## Operating Waveforms (Cont.)

(Refer to the section "Typical Application Circuits"  $V_{CNTL}=5V$ ,  $V_{IN}=V_{REF}=1.8V$ ,  $T_A=25^\circ C$ )

**VTT Load Transient Response**

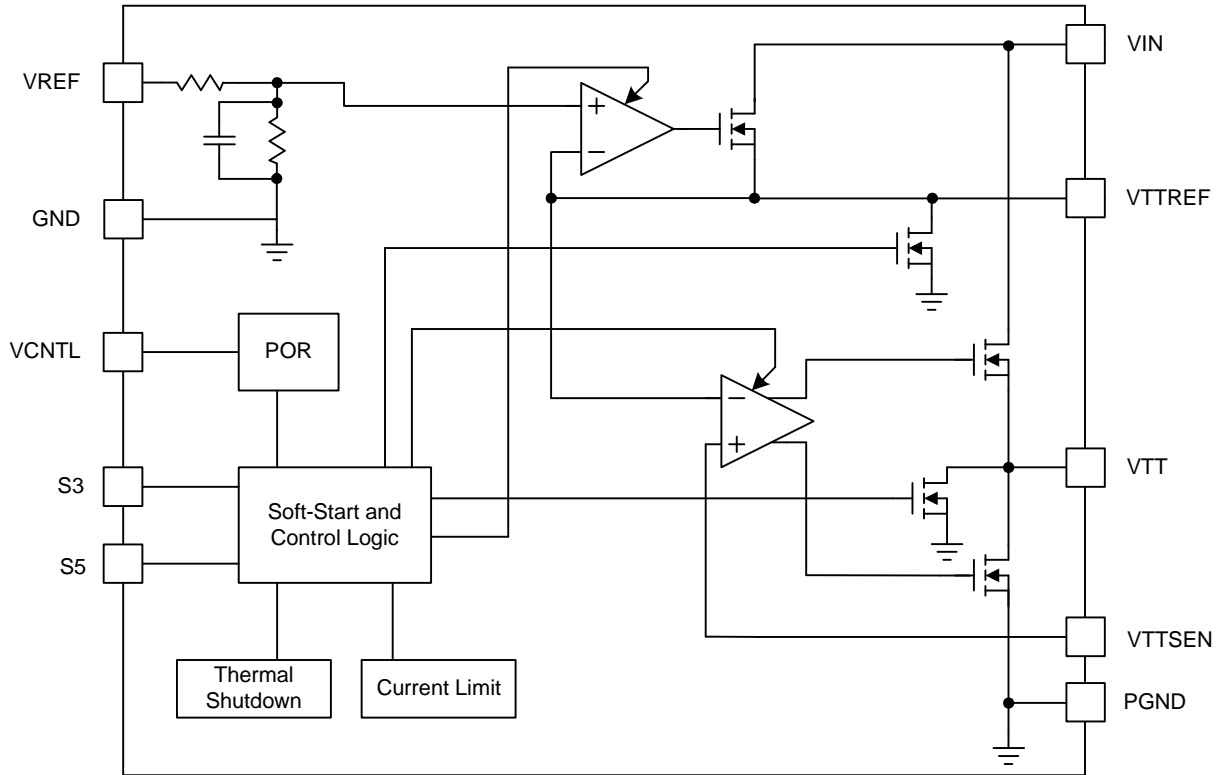


$I_{VTT}=-2A$  (Sink) to  $2A$  (Source) to  $-2A$   
 CH1:  $V_{TTREF}$ , 50mV/Div, DC  
 CH2:  $V_{TT}$ , 50mV/Div, DC  
 CH3:  $I_{VTT}$ , 2A/Div, DC  
 TIME:100 $\mu$ s/Div

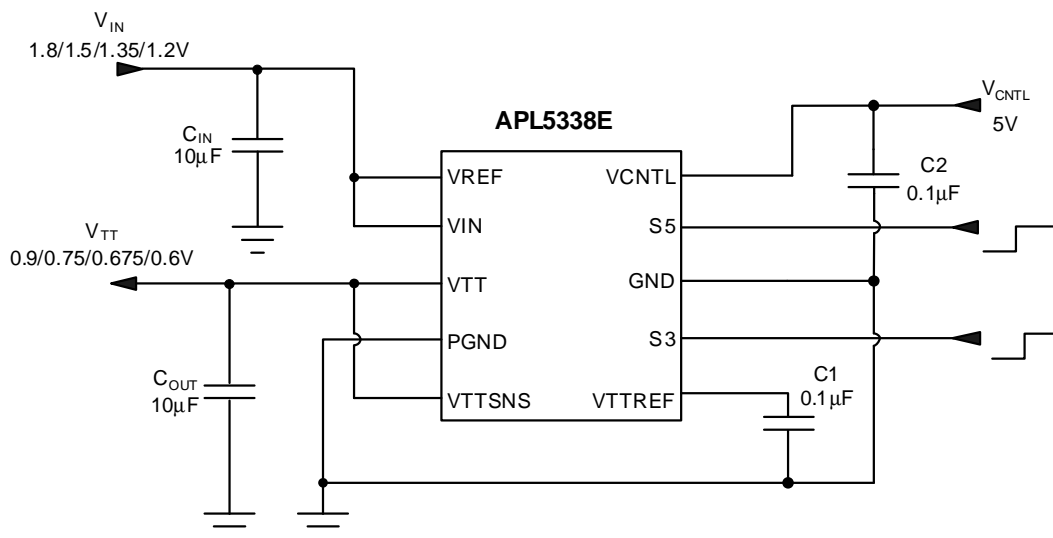
## Pin Description

PIN		I/O	FUNCTION
NO.	NAME		
1	VREF	I	Reference Voltage Input for VTT and VTTREF Regulator.
2	VIN	I	Power Input for VTT and VTTREF Pin. An input capacitor should be connected from VIN to PGND.
3	VTT	O	VTT Output Voltage Pin. Source and sink current up to 2A. To insure the stability issue, the output capacitor typical 10 $\mu$ F should be connected from VTT to PGND.
4	PGND	I/O	Power Ground for VIN and VTT.
5	VTTSENS	I	Voltage Sense for VTT. Connect to the positive node of $V_{TT}$ output capacitors.
6	VTTREF	O	VTT Reference Output Pin. A small capacitor 0.1 $\mu$ F should be connected from VTTREF to GND.
7	S3	I	S3 Signal Input.
8	GND	I/O	Signal Ground.
9	S5	I	S5 Signal Input.
10	VCNTL	I	Power Input for Internal Control Circuitry. A bypass capacitor 0.1 $\mu$ F should be connected near the pin.

Block Diagram



Typical Application Circuit



## Function Description

### VTT Source/Sink Regulator

The APL5338E is a low dropout source/sink linear regulator with maximum 2A source/sink current. Two internal N-channel MOSFETs controlled by separate high bandwidth error amplifiers regulate the output voltage by sourcing current from VIN or sinking current to PGND. To prevent two pass elements from shoot-through, a voltage offset is created between two positive inputs of the error amplifiers.

### Power-On-Reset (POR)

The APL5338E monitors the VCNTL pin voltage for power-on-reset function to prevent erroneous operation. The built-in POR circuit keeps the outputs shutoff until internal circuit is operating properly. Typical POR threshold is 2.8V with 0.2V hysteresis.

### VTTREF Regulator

VTTREF voltage follows 1/2VREF voltage which is the reference of the VTT regulator. The VTTREF block consists of a resistor divider and a low pass filter. The regulator can source current up to 20mA (typical). To insure the stability, a 0.1μF ceramic capacitor should be connected from VTTREF to GND.

### Soft-Start and Current Limit

The APL5338E monitors the output current, both sourcing and sinking current, and limits the maximum output current to prevent damages during current overload or short circuit (shorted from VOUT to GND or VIN) conditions. The APL5338E provides a soft-start function, using the constant current to charge the output capacitor that gives a rapid and linear output voltage rise. If the load current is above the current limit start-up, the VTT cannot start successfully.

Table1. The truth table of S3 and S5 pins

STATE	S3	S5	VTTREF	VTT
S0	H	H	1	1
S3	L	H	1	0(high-Z)
S4/5	L	L	0(discharge)	0(discharge)

### S3, S5 Control

The S3 and S5 signals control the VTT and VTTREF states and these pins should be connected to SLP\_S3 and SLP\_S5 signals respectively. The table1 shows the truth table of the S3 and S5 pins. When both S3 and S5 are above the logic threshold voltage, the VTT and VTTREF are turned on at S0 state. When S3 is low and S5 is high, the VTT voltage is disabled and left high impedance in S3 state. When both S3 and S5 are low, the VTT and VTTREF are turned off and discharged to the ground through internal MOSFETs during S4/S5 state. (Note that if the S3 is forced high and S5 is forced low, then VTTREF is discharged and VTT is at high-Z state. Such condition is not recommended.)

### Thermal Shutdown

A thermal shutdown circuit limits the junction temperature of the APL5338E. When the junction temperature exceeds +150°C, the device will turn off the MOSFETs, allowing the device to cool down. The regulator regulates the output again through initiation of a new soft-start cycle after the junction temperature cools by 30°C, resulting in a pulsed output during continuous thermal overload conditions. The thermal shutdown is designed with a 30°C hysteresis to lower the average junction temperature during continuous thermal overload conditions, extending lifetime of the device. For normal operation, device power dissipation should be externally limited so that junction temperatures will not exceed +125°C.

## Application Information

### Input Capacitor

The APL5338E requires proper input capacitors to supply surge current during stepping load transients to prevent the input rail from dropping. Because the parasitic inductor from the voltage sources or other bulk capacitors to the VIN limits the slew rate of the surge current, it is necessary to place the input capacitors near VIN as close as possible. Input capacitors should be greater than 10µF. A capacitor of 0.1µF (MLCC) or above is recommended for VCNTL pin noise decoupling.

### Output Capacitor

The APL5338E needs a proper output capacitor to maintain circuit stability and improve transient response over temperature and current. In order to insure the circuit stability, a 10µF MLCC (minimum) as an output capacitor must be placed near the VTT. With X5R and X7R dielectrics.

### Thermal Consideration

The APL5338E maximum power dissipation depends on the differences of the thermal resistance and temperature between junction and ambient air. The power dissipation  $P_D$  across the device is:

$$P_D = (T_J - T_A) / \theta_{JA}$$

where  $(T_J - T_A)$  is the temperature difference between the junction and ambient air.  $\theta_{JA}$  is the thermal resistance between junction and ambient air. Assuming the  $T_A = 25^\circ\text{C}$  and maximum  $T_J = 150^\circ\text{C}$  (typical thermal limit threshold), the maximum power dissipation is calculated as:

$$P_{D(max)} = (150 - 25) / 80 = 1.56(\text{W}) \quad \dots\dots\dots T_A = 25^\circ\text{C}$$

For normal operation, do not exceed the maximum operating junction temperature of  $T_J = 125^\circ\text{C}$ . The calculated power dissipation should be less than:

$$P_D = (125 - 25) / 80 = 1.25(\text{W}) \quad \dots\dots\dots T_A = 25^\circ\text{C}$$

The exposed pad provides an electrical connection to ground and channels heat away. Connect the exposed pad to ground by using a large ground plane.

### Layout Consideration

Figure 1 illustrates the layout. Below is a checklist for your layout:

1. Please place the input capacitors close to the VIN.
2. Output capacitors for VTT must be close to the pin with short and wide track.
3. VTTSENS should be connected to the output capacitors of VTT separated from large current path to avoid effect of ESR and ESL. The ESR and ESL of ground track between VTT and GND should be minimized.
4. VREF should be connected to VIN by a separate track. VREF is the reference voltage of VTTREF, so avoid any noise to get into the VREF.
5. PGND is the ground of VIN and VTT. GND is the signal ground of VREF, VTTREF S3 and S5. GND and PGND should be isolated with a single point connection between them.
6. Soldering the exposed pad to ground is good for heatsinking. Numerous vias 0.33 mm in diameter connected from the thermal land to the internal/solder-side ground plane(s) should be used to enhance dissipation.

Large ground plane is good for heatsinking. Optimum performance can only be achieved when the device is mounted on a PC board according to the board layout diagrams which are shown as Figure 2.

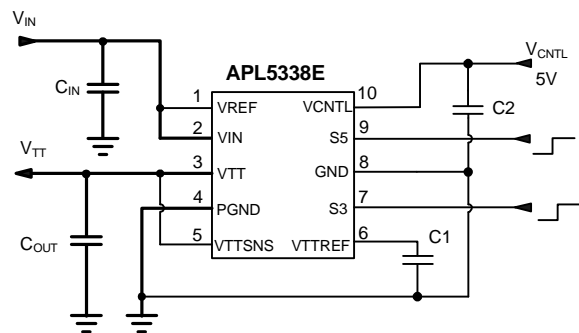
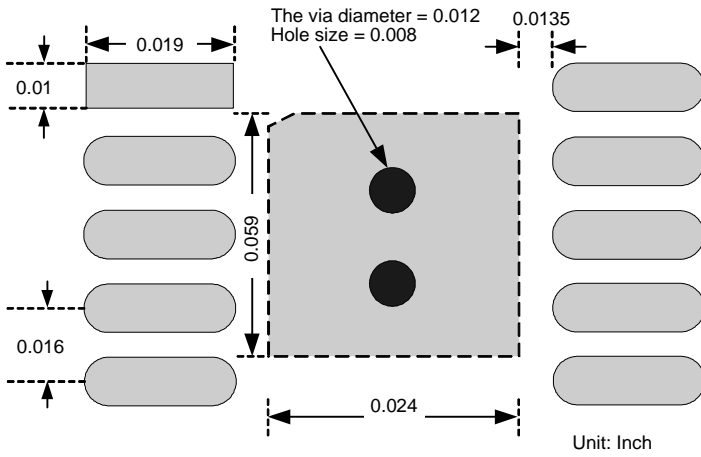


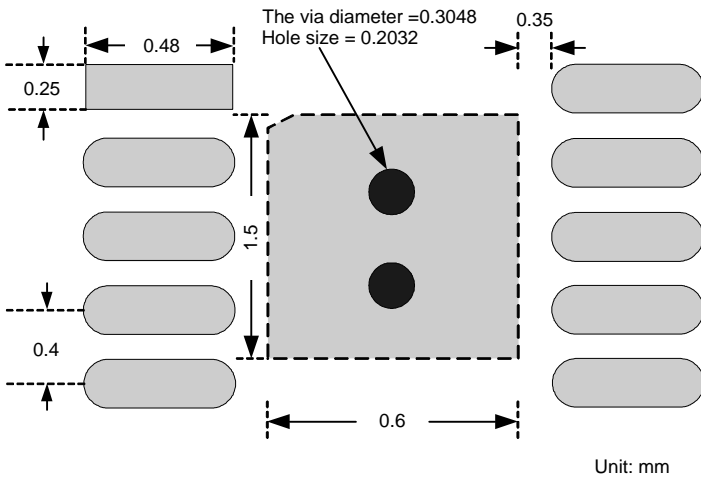
Figure 1

Application Information (Cont.)

Recommended Minimum Footprint



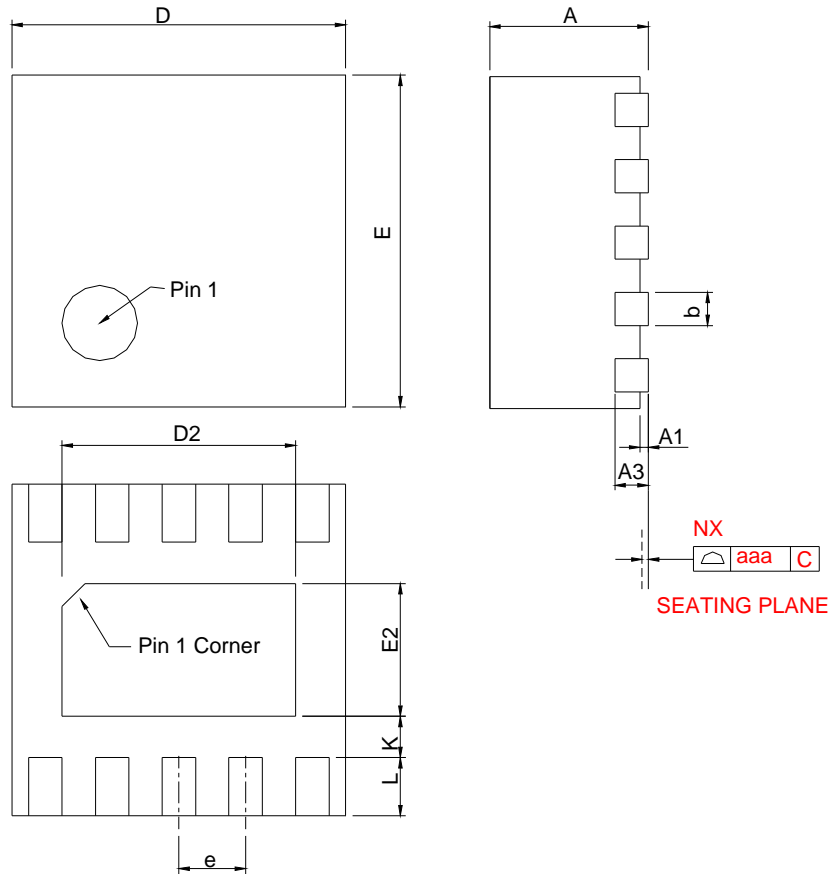
TDFN2x2-10



TDFN2x2-10

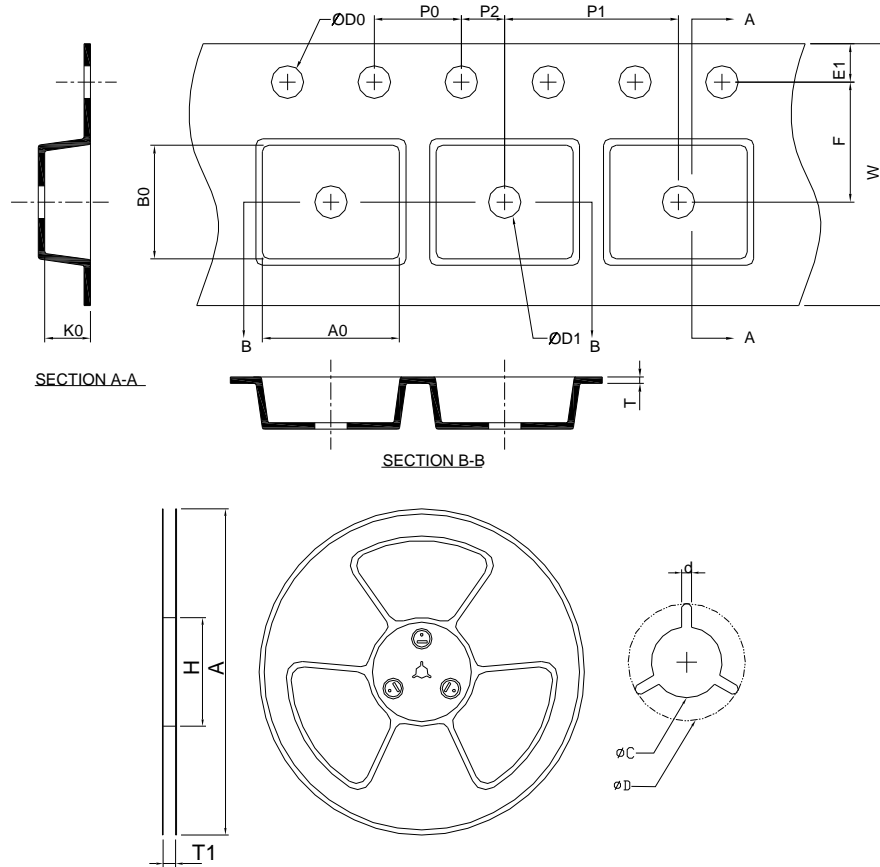
Package Information

TDFN2x2-10



SYMBOL	TDFN2x2-10			
	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	0.70	0.80	0.028	0.031
A1	0.00	0.05	0.000	0.002
A3	0.20 REF		0.008 REF	
b	0.15	0.25	0.006	0.010
D	1.90	2.10	0.075	0.083
D2	1.40	1.60	0.055	0.063
E	1.90	2.10	0.075	0.083
E2	0.50	0.70	0.020	0.028
e	0.40 BSC		0.016 BSC	
L	0.30	0.40	0.012	0.016
K	0.20		0.008	
aaa	0.08		0.003	

Carrier Tape & Reel Dimensions



Application	A	H	T1	C	d	D	W	E1	F
TDFN2x2-10	178.0±2.00	50 MIN.	8.4+2.00 -0.00	13.0+0.50 -0.20	1.5 MIN.	20.2 MIN.	8.0±0.20	1.75±0.10	3.5±0.05
	P0	P1	P2	D0	D1	T	A0	B0	K0
	4.0±0.10	4.0±0.10	2.0±0.05	1.5+0.10 -0.00	1.5 MIN.	0.6+0.00 -0.40	2.35±0.20	2.35±0.20	1.00±0.20

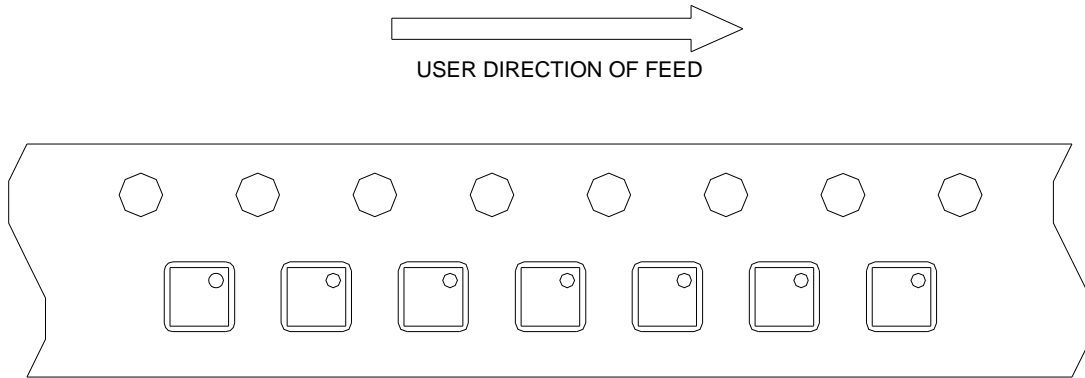
(mm)

Devices Per Unit

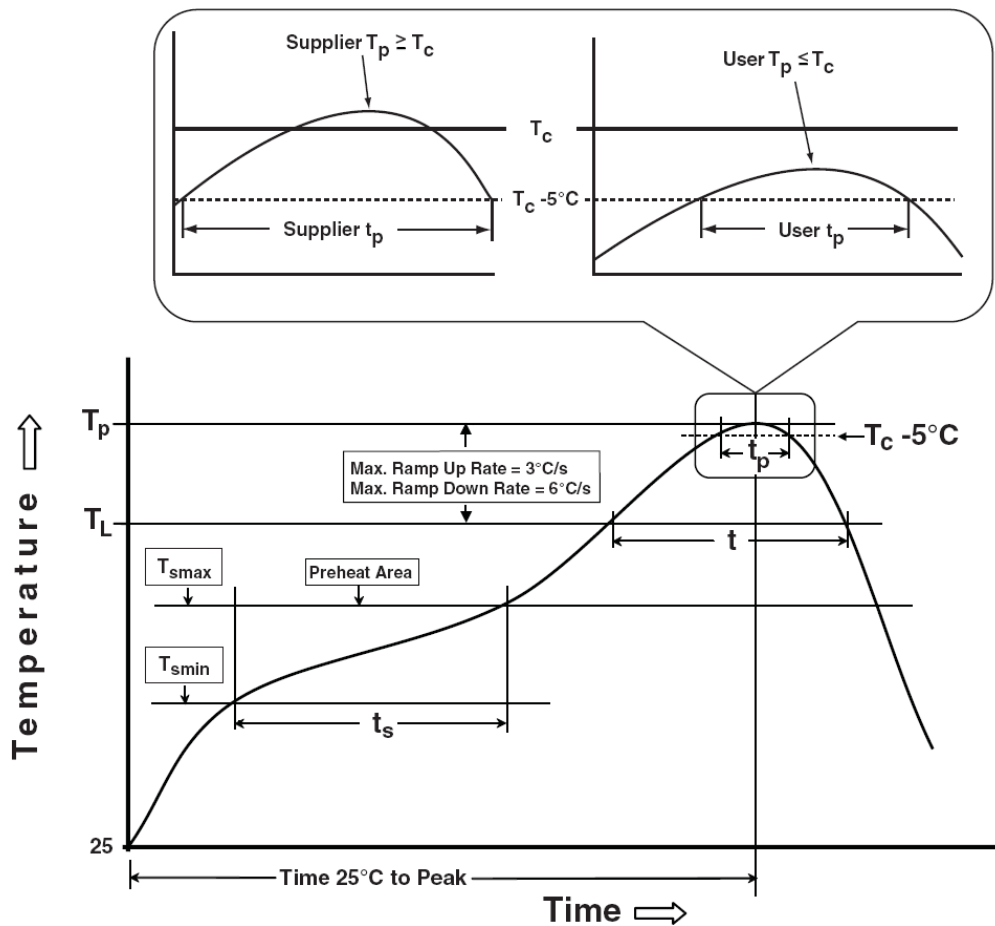
Package Type	Unit	Quantity
TDFN2x2-10	Tape & Reel	3000

### Taping Direction Information

TDFN2x2-10



### Classification Profile





### Classification Reflow Profiles

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
<b>Preheat &amp; Soak</b>		
Temperature min ( $T_{smin}$ )	100 °C	150 °C
Temperature max ( $T_{smax}$ )	150 °C	200 °C
Time ( $T_{smin}$ to $T_{smax}$ ) ( $t_s$ )	60-120 seconds	60-120 seconds
Average ramp-up rate ( $T_{smax}$ to $T_p$ )	3 °C/second max.	3°C/second max.
Liquidous temperature ( $T_L$ )	183 °C	217 °C
Time at liquidous ( $t_L$ )	60-150 seconds	60-150 seconds
Peak package body Temperature ( $T_p$ )*	See Classification Temp in table 1	See Classification Temp in table 2
Time ( $t_p$ )** within 5°C of the specified classification temperature ( $T_c$ )	20** seconds	30** seconds
Average ramp-down rate ( $T_p$ to $T_{smax}$ )	6 °C/second max.	6 °C/second max.
Time 25°C to peak temperature	6 minutes max.	8 minutes max.
* Tolerance for peak profile Temperature ( $T_p$ ) is defined as a supplier minimum and a user maximum.		
** Tolerance for time at peak profile temperature ( $t_p$ ) is defined as a supplier minimum and a user maximum.		

Table 1. SnPb Eutectic Process – Classification Temperatures ( $T_c$ )

Package Thickness	Volume mm <sup>3</sup> <350	Volume mm <sup>3</sup> ≥350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

Table 2. Pb-free Process – Classification Temperatures ( $T_c$ )

Package Thickness	Volume mm <sup>3</sup> <350	Volume mm <sup>3</sup> 350-2000	Volume mm <sup>3</sup> >2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

### Reliability Test Program

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HOLT	JESD-22, A108	1000 Hrs, Bias @ $T_j=125^\circ\text{C}$
PCT	JESD-22, A102	168 Hrs, 100%RH, 2atm, 121°C
TCT	JESD-22, A104	500 Cycles, -65°C~150°C
HBM	MIL-STD-883-3015.7	VHBM ≥ 2KV
MM	JESD-22, A115	VMM ≥ 200V
Latch-Up	JESD 78	10ms, $1_{tr} \geq 100\text{mA}$

---

## Customer Service

### **Anpec Electronics Corp.**

Head Office :

No.6, Dusing 1st Road, SBIP,

Hsin-Chu, Taiwan, R.O.C.

Tel : 886-3-5642000

Fax : 886-3-5642050

Taipei Branch :

2F, No. 11, Lane 218, Sec 2 Jhongsing Rd.,

Sindian City, Taipei County 23146, Taiwan

Tel : 886-2-2910-3838

Fax : 886-2-2917-3838